



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:
MARUYAMA, Shigeyuki et al.

Group Art Unit: **2829**

Serial No.: **10/685,542**

Examiner: **Russell M. Kobert**

Filed: **October 16, 2003**

For: **SEMICONDUCTOR TESTING DEVICE**

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT
PURSUANT TO 37 CFR 1.97(b)

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450 November 21, 2003

Sir:

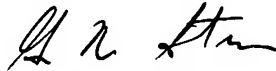
This is a Supplement Information Disclosure Statement to the Information Disclosure Statement as originally filed on October 16, 2003. In compliance with 37 CFR 1.56, Applicants call to the attention of the Patent and Trademark Office the references listed on the attached PTO-1449. The documents listed on the Form PTO-1449 were made of record in prior application Serial No. 09/828,221.

No fee or certification is required in connection with this Supplemental Information Disclosure Statement, since it is being submitted prior to the issuance of a first official action on the merits or expiration of the three month period following the filing date or the entry of the national stage of the above-captioned application.

The Commissioner is authorized to charge our Deposit Account No. 01-2340 for any fee which is deemed by the Patent and Trademark Office to be required to effect consideration of this statement.

Respectfully submitted,

ARMSTRONG, KRATZ, QUINTOS,
HANSON & BROOKS, LLP



George N. Stevens
Attorney for Applicants
Reg. No. 36,938

GNS/xl
Atty. Docket No. **990250B**
Suite 1000
1725 K Street, N.W.
Washington, D.C. 20006
(202) 659-2930



23850

PATENT TRADEMARK OFFICE

Enclosure: PTO-1449



INFORMATION DISCLOSURE CITATION PTO-1449	Atty. Docket No. 990250B	Serial No.: 10/685,542
	Applicant(s): MARUYAMA, Shigeyuki et al.	
	Filing Date: October 16, 2003	Group Art Unit: 2829

U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
	AA	5,810,609	Faraci et al.	09/22/1998	439	71	
	AB	5,983,492	Fjelstad	11/16/1999	29	843	
	AC	6,499,216	Fjelstad	12/31/2002	29	842	
	AD	6,229,100	Fjelstad	05/08/2001	174	261	
	AE	5,518,964	DiStefano et al.	05/21/1996	437	209	
	AF	5,688,716	DiStefano et al.	11/18/1997	437	182	
	AG	5,706,174	DiStefano et al.	01/06/1998	361	749	
	AH	5,801,441	DiStefano et al.	09/01/1998	257	696	
	AI	5,830,782	Smith et al.	11/03/1998	438	123	
	AJ	5,913,109	DiStefano et al.	06/15/1999	438	117	
	AK	5,959,354	Smith et al.	09/28/1999	257	734	
	AL	5,989,936	Smith et al.	11/23/1999	438	106	
	AM	6,012,224	DiStefano et al.	01/11/2000	29	840	
	AN	6,080,603	DiStefano et al.	06/27/2000	438	117	

FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Translation (Yes or No)
	AO	8-31888	02/02/1996	Japan	Abstract
	AP	10-256314	09/25/1998	Japan	Abstract

OTHER DOCUMENTS

	AQ	Notice of Reasons of Rejection issued April 30, 2002 by the Japan Patent Office w/ the partial translation
Examiner	Date Considered	